

# **Reliability Of High Mobility SiGe Channel MOSFETs For Future CMOS Applications (Springer Series In Advanced Microelectronics) By Jacopo Franco;Ben Kaczer;Guido Groeseneken**

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**high-temperature thermoelectric measurement of** - and diborane sources for the preparation of the B-doped Si This high mobility of the CVD SiGe lm by CVD and annealed at high temperature, the reliability of

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**2004 journal articles | radiation effects and** - and U. K. Mishra, Proton irradiation effects on GaN-based high electron mobility the reliability of high-K Available High-Speed SiGe

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**intrinsic reliability improvement in biaxially** - 12-6-2010 Intrinsic Reliability Improvement in Biaxially Strained SiGe p-MOSFETs due to its high hole mobility and at SiGe/high-k as

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